

<b>Notice of References Cited</b>	Application/Control No. 10/710,581	Applicant(s)/Patent Under Reexamination HWANG ET AL.	
	Examiner Tuan H. Nguyen	Art Unit 2813	Page 1 of 1

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*	B	US-2005/0081781	04-2005	Lin et al.	117/104
*	C	US-2005/0118353	06-2005	Chen et al.	427/569
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**NON-PATENT DOCUMENTS**

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